

JP 07047272A

(No Japanese language document provided – English language abstract and English language translation of JP 07047272 A provided.)

This document discloses a generic catalyst composition of the formula:



wherein Q is Cr or In; A is K, Rb, Cs; E is Mg, Mn, Zn, Ce, Na, or P.

CN 1114915A

(Chinese language document and English language translation provided.)

This document discloses a generic catalyst composition of the formula:



wherein A is K, Rb, Cs, Sm, Th; B is Mn, Mg, Sr, Ca, Ba, La, rare earth, C is P, As, B, Sb, Cr; M is W, V. This document also describes the diameter of colloidal particles (10-200nm, 15-90 nm preferred) of silicon sol.

JP 020045696

(Machine translation to English provided.)

This document discloses a generic catalyst composition of the formula:



wherein H is Mg, Ca, Sr, Ba, Cr, Mn, Co, Ni, Cu, Zn or Cd; L is Y, La, Pr, Nd, Sm, Al, Ga, or In; M is Ti, Zr, V, Nb, Ta, W, Ge, Sn, Pb or Sb; N is Ru, Rh, Pd, Re, Os, Ir, Pt, or Ag; X is P, B, As, Tl, or Te, Y is Li, Na, K, Rb, or Ce. The composition of Example 3 may be relevant to the patentability of the invention claimed in the above-identified application.

CN 1302690 A

(Chinese language document and partial English language translation provided.)

This document discloses a generic catalyst composition of the formula:



wherein X is Mg, Co, Ca, Be, Cu, Zn, Pb, Sb, Mn, or Cr; Y is La, or Ce, Sm; Z is K, Rb, Na, or Cs; Q is B, W, or V. The composition of Example 7 may be relevant to the patentability of the invention claimed in the above-identified application.

CN 1310046 A

(Chinese language document and partial English language translation provided.)

This document discloses a generic catalyst composition of the formula:



wherein A is Li, Na, K, Rb, or Cs; B is Co, Ni, Cr, Ca, Mg, La, Ce, or V; C is B, P, or As. The composition of Example 8 may be relevant to the patentability of the invention claimed in the above-identified application.

CN 1310172 A

(Chinese language document and English language translation provided.)

This document discloses a generic catalyst composition of the formula:

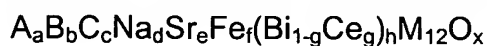


wherein A is Li, Na, K, Rb, or Cs; B is Co, Ni, Cr, Ca, Ce, La, Cu, or V; C is B, P, or As. The composition of Example 5 may be relevant to the patentability of the invention claimed in the above-identified application.

CN 1230459A

(Chinese language document and partial English language translation provided.)

This document discloses a generic catalyst composition of the formula:



wherein A is Li, K, Rb, or Cs; B is Mg or Zn; C is Ni, Co, Mn, Cr, Sb, P, W, or V.

WO 01/14057A

(Chinese language document and partial English language translation provided.)

This document discloses a generic catalyst composition of the formula:

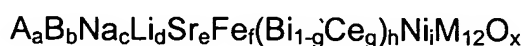


wherein A is Li, K, Rb, Cs, Sm, In, or Tl; B is at least two of P, Sb, Cr, W, Pr, Ce, As, B, Te, Ga, Al, Nb, Tb, La, or V; C is Ni, Co, Sr, Mn, Mg, Ca, Zn, Cd, or Cu.

CN 1287882A

(Chinese language document and English language translation provided.)

This document discloses a generic catalyst composition of the formula:



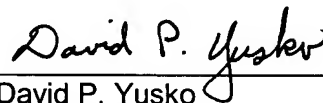
wherein A is K, Rb, Cs, Tl or Sm; B is Mg, Zn, Co, Mn, Cr, P, Sb, B, W, or V.

The documents listed on the accompanying form are for the Examiner's convenience and do not constitute an admission that the documents so listed are, in fact, prior art with respect to the present application. Further, with respect to the foreign patent documents, while the above description is believed to reflect the relevant contents of the document, it is not intended that the Patent and Trademark Office rely upon this description as unfailingly accurate or complete. Rather, an English language copy of each document is included for the express purpose of providing the Patent and Trademark Office with ample opportunity to evaluate the same and to arrive at an independent assessment of the materiality of the document, if any, to the examination of this application.

Applicants respectfully request that the art listed on the accompanying form entitled "List of Documents cited by Applicant" be made of record in the above-stylized case.

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Respectfully submitted,



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U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
37,437SERIAL NO.
10/717,130LIST OF DOCUMENTS CITED BY APPLICANT
(Use several sheets if necessary)

APPLICANTS

Christos Paparizos, Stephen C. Jevne, Michael J. Seely

FILING DATE

November 18, 2003

GROUP

UNKNOWN

FEB 27 2004

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
AA	4 2 2 8 0 9 8	10/14/80	Aoki et al.	260	465.3	
AB	4 4 1 4 1 3 3	11/08/83	Otake et al.	502	179	
AC	4 6 5 9 6 8 9	04/21/87	Suresh et al.	502	311	
AD	4 7 4 6 7 5 3	05/24/88	Brazdil, Jr. et al.	558	324	
AE	4 9 3 9 2 8 6	07/03/90	Brazdil et al.	558	324	
AF	5 0 9 3 2 9 9	03/03/92	Suresh et al.	502	212	
AG	5 1 3 4 1 0 5	07/28/92	Paparizos et al.	502	205	
AH	5 1 7 5 3 3 4	12/29/92	Suresh et al.	558	324	
AI	5 2 1 2 1 3 7	05/18/93	Suresh et al.	502	212	
AJ	5 2 3 5 0 8 8	08/10/93	Paparizos et al.	558	324	
AK	5 3 6 4 8 2 5	11/15/94	Neumann et al.	502	311	

FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
AL JP 07 04 72 72 A 2	02/21/95	Japan			x
AM C N 11 14 91 5 A	01/17/96	China			X
AN JP 02 00 45 69 6 A	02/12/02	Japan			X
AO C N 13 02 69 0 A	07/11/01	China			X
AP C N 13 10 04 6 A	02/24/00	China			X

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

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EXAMINER

DATE CONSIDERED

* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE										ATTY. DOCKET NO. 37,437		SERIAL NO. 10/717,130	
LIST OF DOCUMENTS CITED BY APPLICANT <i>(Use several sheets if necessary)</i>										APPLICANTS Christos Paparizos, Stephen C. Jevne, Michael J. Seely			
										FILING DATE November 18, 2003		GROUP UNKNOWN	

U.S. PATENT DOCUMENTS														
*EXAMINER INITIAL		DOCUMENT NUMBER								DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AU	5	5	8	3	0	8	4	12/10/96	Martin et al.	502	211		
	AV	5	5	8	3	0	8	6	12/10/96	Tenten et al.	502	249		
	AW	5	6	5	8	8	4	2	08/19/97	Midorikawa et al.	502	314		
	AX	5	6	6	3	1	1	3	10/02/97	Midorikawa et al.	502	314		
	AY	5	7	8	0	6	6	4	07/14/98	Kunitoshi Aoki	558	323		
	AZ	5	8	0	8	1	4	3	09/15/98	Karrer et al.	562	407		
	BA	5	8	4	0	6	4	8	11/24/98	Suresh et al.	502	306		
	BB	6	1	4	3	6	9	0	11/07/00	Komada et al.	502	211		
	BC	5	8	3	4	3	9	4	11/10/98	Chen et al.	502	302		
	BD	6	4	5	8	7	4	2	10/01/02	Paparizos et al.	502	301		
	BE													

FOREIGN PATENT DOCUMENTS															
		DOCUMENT NUMBER								DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
														YES	NO
	BF	C	N	13	10	17	2	A	08/29/01	China				X	
	BG	C	N	12	30	45	9	A	10/06/99	China				X	
	BH	W	O	01	14	05	7	A	03/01/01	China				X	
	BI	C	N	12	87	88	2	A	03/21/01	China				X	
	BJ														

OTHER DOCUMENTS <i>(Including Author, Title, Date, Pertinent Pages, etc.)</i>		
	BK	
	BL	
	BM	

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